

Search Notes**Application/Control No.**

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Examiner

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Applicant(s)/Patent under Reexamination

CHOU ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
331	1A,1R, DIG.2	5/22/2005	HLN
331	16,18,25	—	
327	2,3,7,12	5/23/2005	
	39,40,42		
	43,47,49		
	141,142		
↓	162,163	↓	↓
Search	Above	11/24/2005	HLN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search; see search history printout	11/26/2005	HLN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner